

# MDU5693

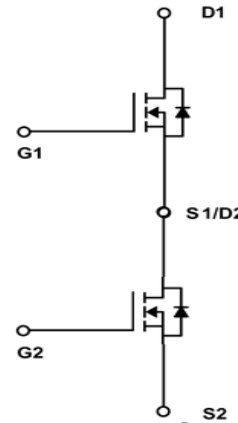
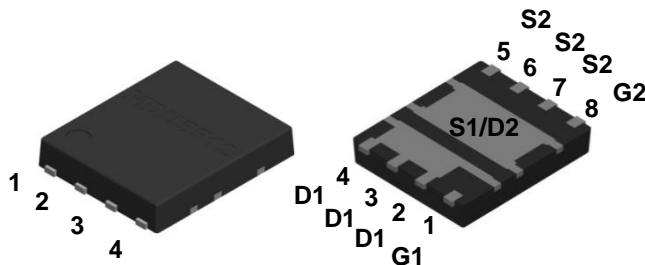
## Dual Asymmetric N-channel Trench MOSFET 30V

### General Description

The MDU5693 uses advanced MagnaChip's MOSFET Technology, which provides high performance in on-state resistance, fast switching performance and excellent quality. MDU5693 is suitable for DC/DC converter and general purpose applications.

### Features

- |  |   |
|--|---|
| <b>FET1</b><br><ul style="list-style-type: none"> <li>▫ <math>V_{DS} = 30V</math></li> <li>▫ <math>I_D = 52A</math></li> <li>▫ <math>R_{DS(ON)} &lt; 5.0m\Omega</math></li> <li>▫ <math>&lt; 8.5m\Omega</math></li> <li>▫ 100% UIL Tested</li> <li>▫ 100% Rg Tested</li> </ul> | <b>FET2</b><br><ul style="list-style-type: none"> <li><math>V_{DS} = 30V</math></li> <li><math>I_D = 100A @ V_{GS} = 10V</math></li> <li><math>&lt; 2.5m\Omega @ V_{GS} = 10V</math></li> <li><math>&lt; 3.2m\Omega @ V_{GS} = 4.5V</math></li> </ul> |
|--|---|



### Absolute Maximum Ratings (Ta = 25°C)

Characteristics		Symbol	FET1	FET2	Unit
Drain-Source Voltage		$V_{DSS}$	30		V
Gate-Source Voltage		$V_{GSS}$	±20	±12	V
Continuous Drain Current <sup>(1)</sup>	$T_C=25^\circ C$ (Silicon Limited)	$I_D$	70	135	A
	$T_C=25^\circ C$ (Package Limited)		52	100	
	$T_C=70^\circ C$		57	108	
	$T_A=25^\circ C$		15.3	25	
	$T_A=70^\circ C$		12.4	20	
Pulsed Drain Current		$I_{DM}$	208	400	A
Power Dissipation	$T_C=25^\circ C$	$P_D$	46.3	73	W
	$T_A=25^\circ C$		2.2	2.5	
Single Pulse Avalanche Energy <sup>(2)</sup>		$E_{AS}$	43	72	mJ
Junction and Storage Temperature Range		$T_J, T_{stg}$	-55~150		°C

### Thermal Characteristics

Characteristics	Symbol	FET1		FET2		Unit
		Typ.	Max	Typ.	Max	
Thermal Resistance, Junction-to-Ambient <sup>(1)</sup>	$R_{\theta JA}$	47.5	57	41.7	50	°C/W
Thermal Resistance, Junction-to-Case	$R_{\theta JC}$	2.2	2.7	1.3	1.7	

## Ordering Information

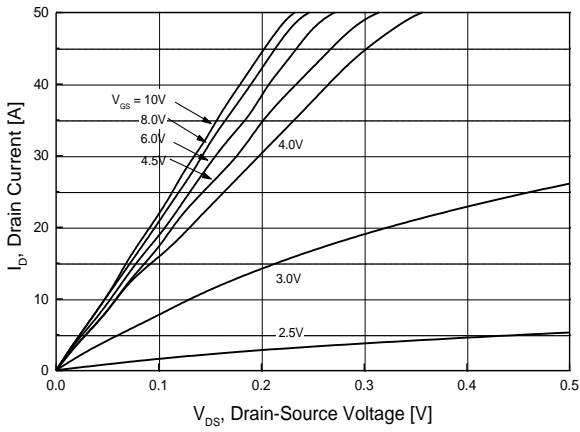
Part Number	Temp. Range	Package	Packing	RoHS Status
MDU5693VRH	-55~150°C	Dual PDFN56	Tape & Reel	Halogen Free

## FET1 Electrical Characteristics (Ta =25°C)

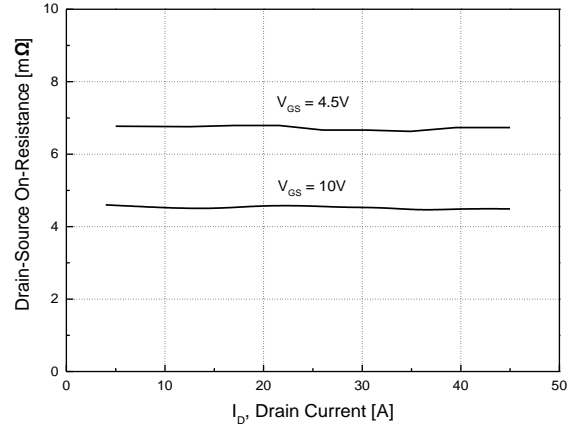
Characteristics	Symbol	Test Condition	Min	Typ	Max	Unit
<b>Static Characteristics</b>						
Drain-Source Breakdown Voltage	$BV_{DSS}$	$I_D = 250\mu A, V_{GS} = 0V$	30	-	-	V
Gate Threshold Voltage	$V_{GS(th)}$	$V_{DS} = V_{GS}, I_D = 250\mu A$	1.0	1.8	3.0	
Drain Cut-Off Current	$I_{DSS}$	$V_{DS} = 30V, V_{GS} = 0V$	-	-	1	$\mu A$
Gate Leakage Current	$I_{GSS}$	$V_{GS} = \pm 20V, V_{DS} = 0V$	-	-	$\pm 0.1$	
Drain-Source ON Resistance	$R_{DS(on)}$	$V_{GS} = 10V, I_D = 20A$	-	4.1	5.0	$m\Omega$
		$T_J = 125^\circ C$	-	5.6	6.8	
		$V_{GS} = 4.5V, I_D = 20A$	-	6.7	8.5	
Forward Transconductance	$g_{fs}$	$V_{DS} = 5V, I_D = 20A$	-	91	-	S
<b>Dynamic Characteristics</b>						
Total Gate Charge	$Q_{g(10V)}$	$V_{DS} = 15.0V, I_D = 20A, V_{GS} = 10V$	14	20	27	$nC$
Total Gate Charge	$Q_{g(4.5V)}$		6.2	9	12	
Gate-Source Charge	$Q_{gs}$		-	6	-	
Gate-Drain Charge	$Q_{gd}$		-	1.9	-	
Input Capacitance	$C_{iss}$	$V_{DS} = 15.0V, V_{GS} = 0V, f = 1.0MHz$	1040	1500	1950	$pF$
Output Capacitance	$C_{oss}$		418	610	790	
Reverse Transfer Capacitance	$C_{rss}$		28	42	55	
Turn-On Delay Time	$t_{d(on)}$	$V_{GS} = 10V, V_{DS} = 15V, I_D = 20A, R_g = 3.0\Omega$	-	10.5	-	$ns$
Rise Time	$t_r$		-	11.3	-	
Turn-Off Delay Time	$t_{d(off)}$		-	28.5	-	
Fall Time	$t_f$		-	5.1	-	
Gate Resistance	$R_g$	$f = 1 MHz$	0.5	1.0	2.0	$\Omega$
<b>Drain-Source Body Diode Characteristics</b>						
Source-Drain Diode Forward Voltage	$V_{SD}$	$I_S = 1A, V_{GS} = 0V$	-	0.7	1.0	V
Body Diode Reverse Recovery Time	$t_{rr}$	$I_F = 20A, di/dt = 200A/\mu s$	-	30.5	-	ns
Body Diode Reverse Recovery Charge	$Q_{rr}$		-	42.9	-	nC

Note :

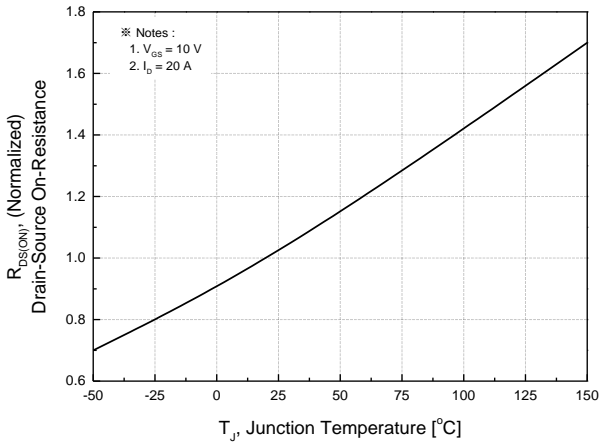
- Surface mounted FR-4 board by JEDEC (jesd51-7). Continuous current at  $T_C = 25^\circ C$  is silicon limited.
- $E_{AS}$  is tested at starting  $T_J = 25^\circ C, L = 0.1mH, I_{AS} = 20 A, V_{DD} = 27V, V_{GS} = 10V$ .



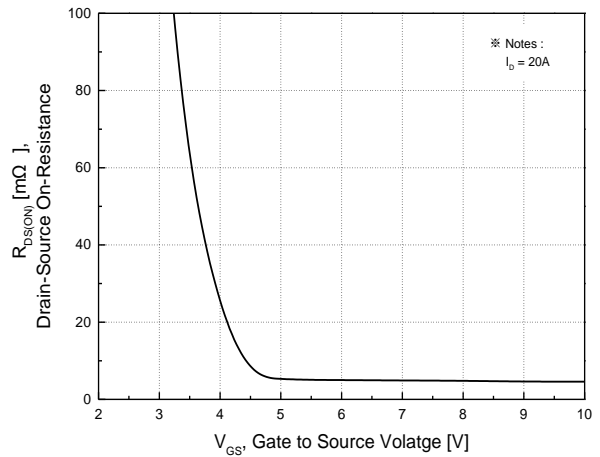
**Fig.1 On-Region Characteristics**



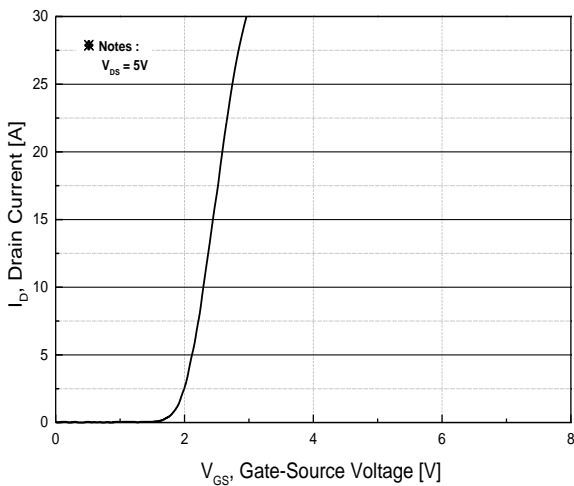
**Fig.2 On-Resistance Variation with Drain Current and Gate Voltage**



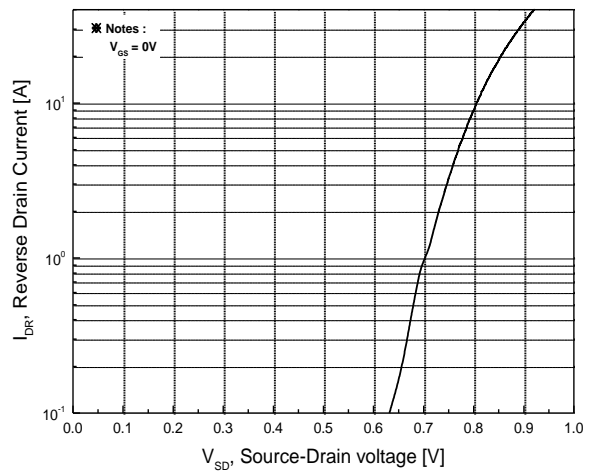
**Fig.3 On-Resistance Variation with Temperature**



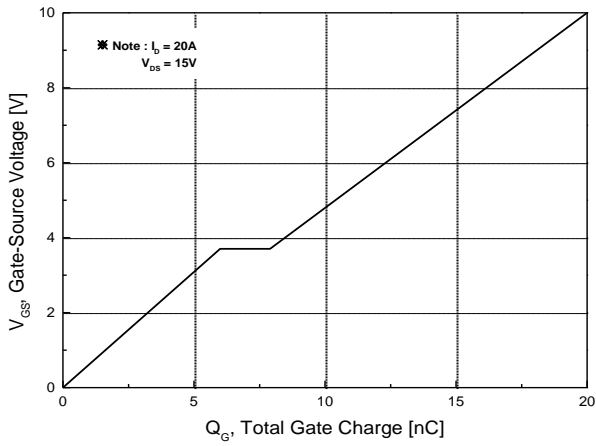
**Fig.4 On-Resistance Variation with Gate to Source Voltage**



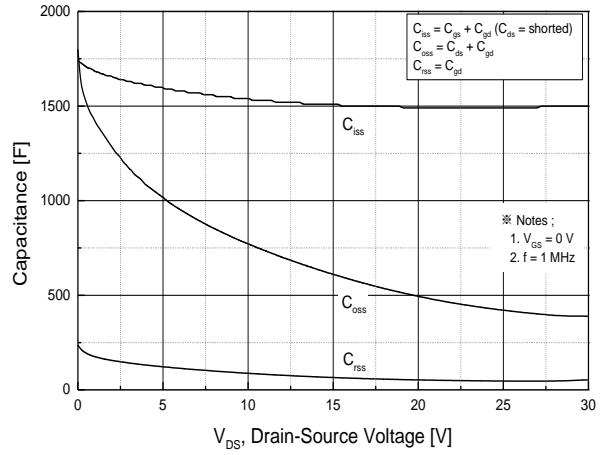
**Fig.5 Transfer Characteristics**



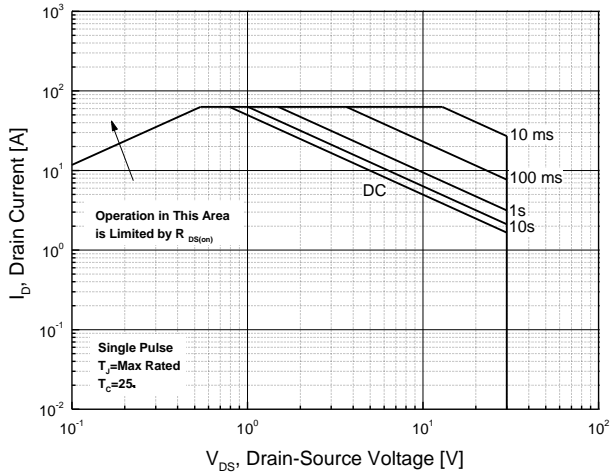
**Fig.6 Body Diode Forward Voltage Variation with Source Current and Temperature**



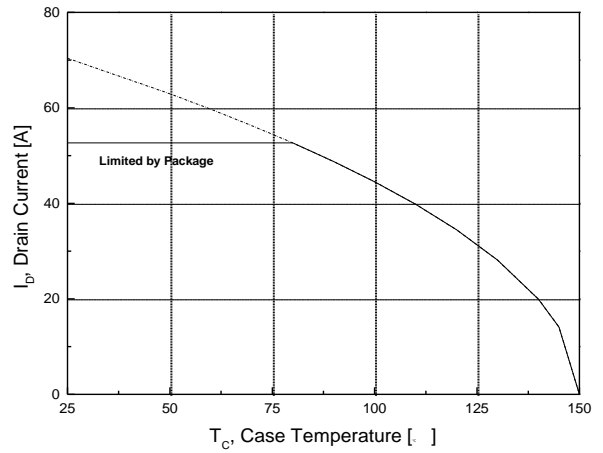
**Fig.7 Gate Charge Characteristics**



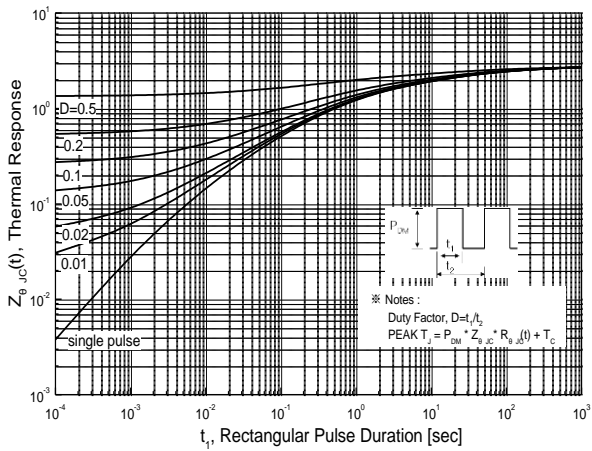
**Fig.8 Capacitance Characteristics**



**Fig.9 Maximum Safe Operating Area**



**Fig.10 Maximum Drain Current vs. Case Temperature**



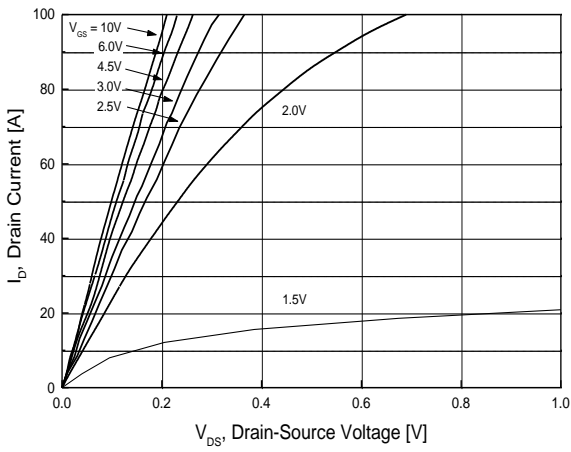
**Fig.11 Transient Thermal Response Curve**

### FET2 Electrical Characteristics (Ta =25°C)

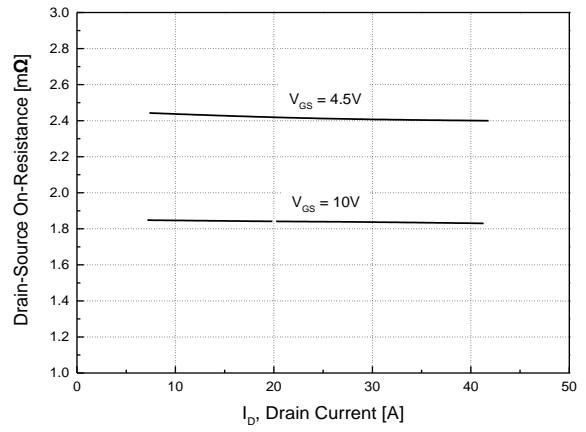
Characteristics	Symbol	Test Condition	Min	Typ	Max	Unit
<b>Static Characteristics</b>						
Drain-Source Breakdown Voltage	$BV_{DSS}$	$I_D = 10mA, V_{GS} = 0V$	30	-	-	V
Gate Threshold Voltage	$V_{GS(th)}$	$V_{DS} = V_{GS}, I_D = 250\mu A$	1.1	1.4	2.2	
Drain Cut-Off Current	$I_{DSS}$	$V_{DS} = 30V, V_{GS} = 0V$	-	-	1	$\mu A$
Gate Leakage Current	$I_{GSS}$	$V_{GS} = \pm 12V, V_{DS} = 0V$	-	-	$\pm 0.1$	
Drain-Source ON Resistance	$R_{DS(on)}$	$V_{GS} = 10V, I_D = 20A$	-	1.8	2.5	m $\Omega$
		$T_J = 125^\circ C$	-	2.3	3.2	
		$V_{GS} = 4.5V, I_D = 20A$	-	2.4	3.2	
Forward Transconductance	$g_{fs}$	$V_{DS} = 5V, I_D = 20A$	-	85	-	S
<b>Dynamic Characteristics</b>						
Total Gate Charge	$Q_{g(10V)}$	$V_{DS} = 15.0V, I_D = 20A, V_{GS} = 10V$	32.8	46.8	65	nC
Total Gate Charge	$Q_{g(4.5V)}$		14.2	20.6	28.8	
Gate-Source Charge	$Q_{gs}$		-	6.8	-	
Gate-Drain Charge	$Q_{gd}$		-	3.9	-	
Input Capacitance	$C_{iss}$	$V_{DS} = 15.0V, V_{GS} = 0V, f = 1.0MHz$	2189	3150	4093	pF
Output Capacitance	$C_{oss}$		690	1010	1300	
Reverse Transfer Capacitance	$C_{rss}$		48	71	92	
Turn-On Delay Time	$t_{d(on)}$	$V_{GS} = 10V, V_{DD} = 15V, I_D = 20A, R_g = 3\Omega$	-	11.3	-	ns
Rise Time	$t_r$		-	12	-	
Turn-Off Delay Time	$t_{d(off)}$		-	57.4	-	
Fall Time	$t_f$		-	7.08	-	
Gate Resistance	$R_g$	$f = 1 MHz$	0.5	1.0	2.0	$\Omega$
<b>Drain-Source Body Diode Characteristics</b>						
Source-Drain Diode Forward Voltage	$V_{SD}$	$I_S = 1.0A, V_{GS} = 0V$	-	0.6	1.0	V
Body Diode Reverse Recovery Time	$t_{rr}$	$I_F = 20A, di/dt = 200A/\mu s$	-	38	-	ns
Body Diode Reverse Recovery Charge	$Q_{rr}$		-	64.4	-	nC

Note :

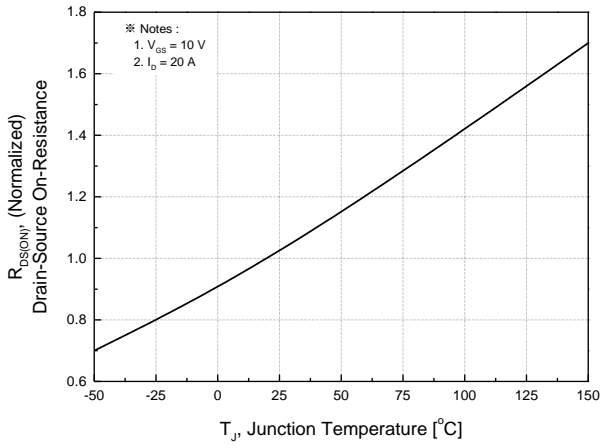
1. Surface mounted FR-4 board by JEDEC (jesd51-7). Continuous current at  $T_C = 25^\circ C$  is silicon limited.
2.  $E_{AS}$  is tested at starting  $T_J = 25^\circ C, L = 0.1mH, I_{AS} = 25 A, V_{DD} = 27V, V_{GS} = 10V$ .



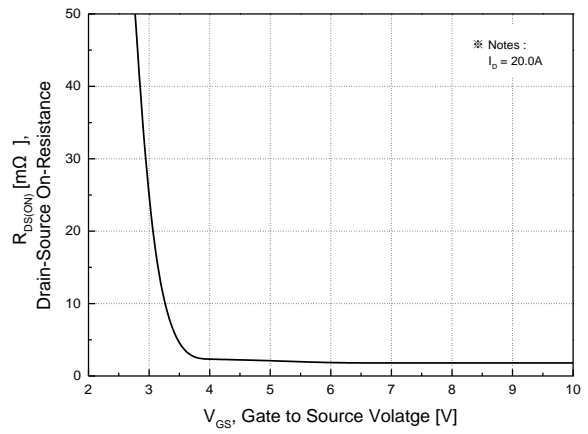
**Fig.1 On-Region Characteristics**



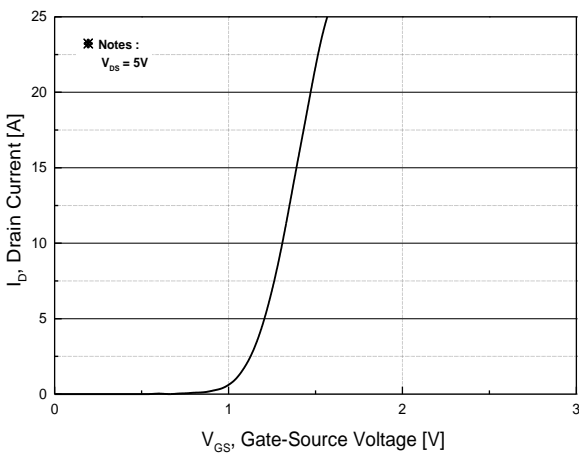
**Fig.2 On-Resistance Variation with Drain Current and Gate Voltage**



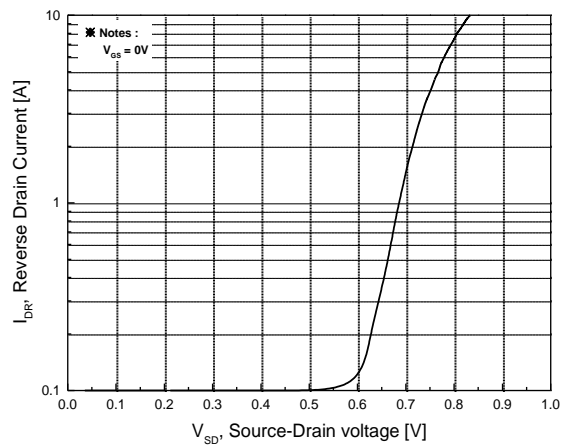
**Fig.3 On-Resistance Variation with Temperature**



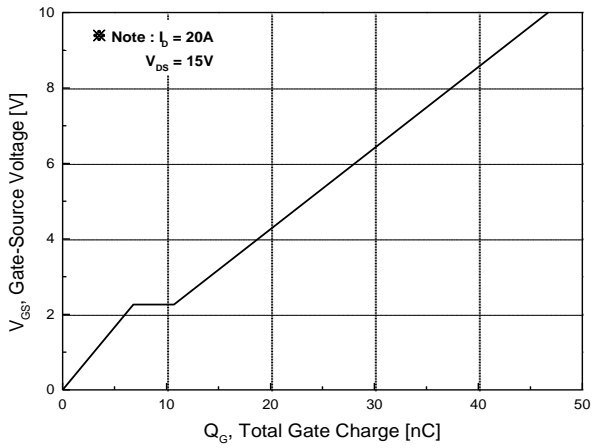
**Fig.4 On-Resistance Variation with Gate to Source Voltage**



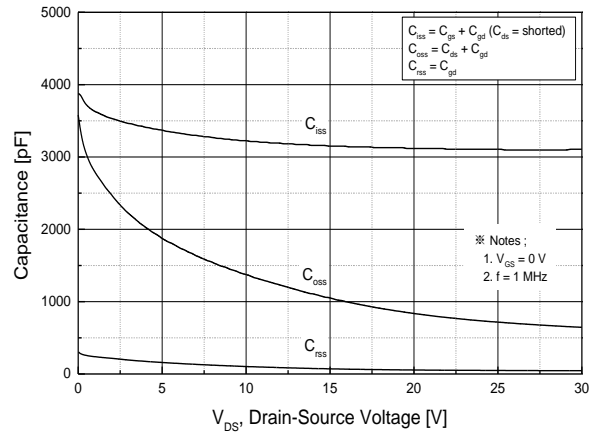
**Fig.5 Transfer Characteristics**



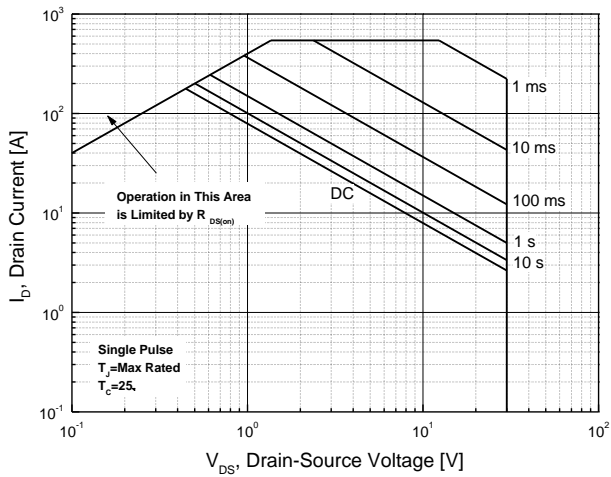
**Fig.6 Body Diode Forward Voltage Variation with Source Current and Temperature**



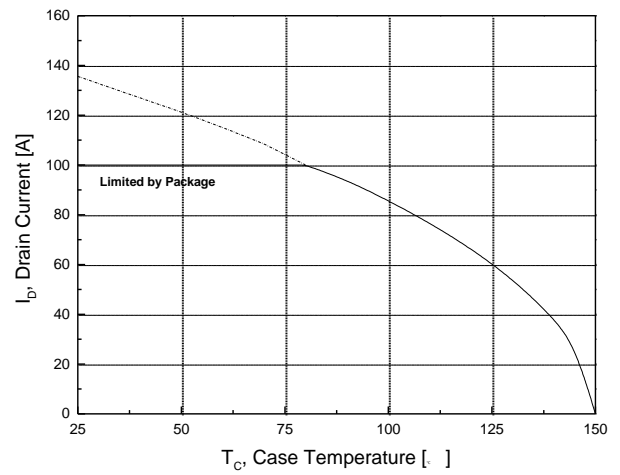
**Fig.7 Gate Charge Characteristics**



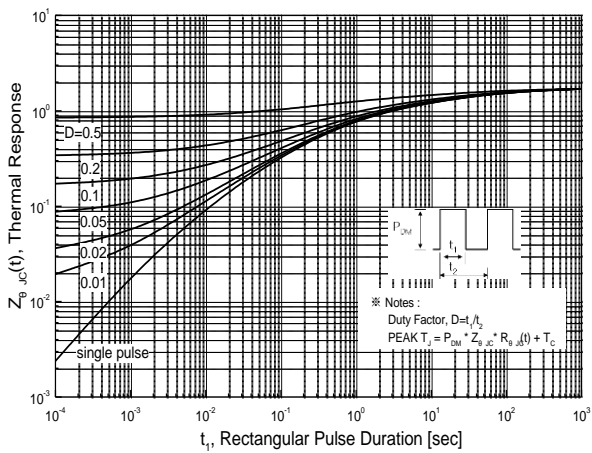
**Fig.8 Capacitance Characteristics**



**Fig.9 Maximum Safe Operating Area**



**Fig.10 Maximum Drain Current vs. Case Temperature**

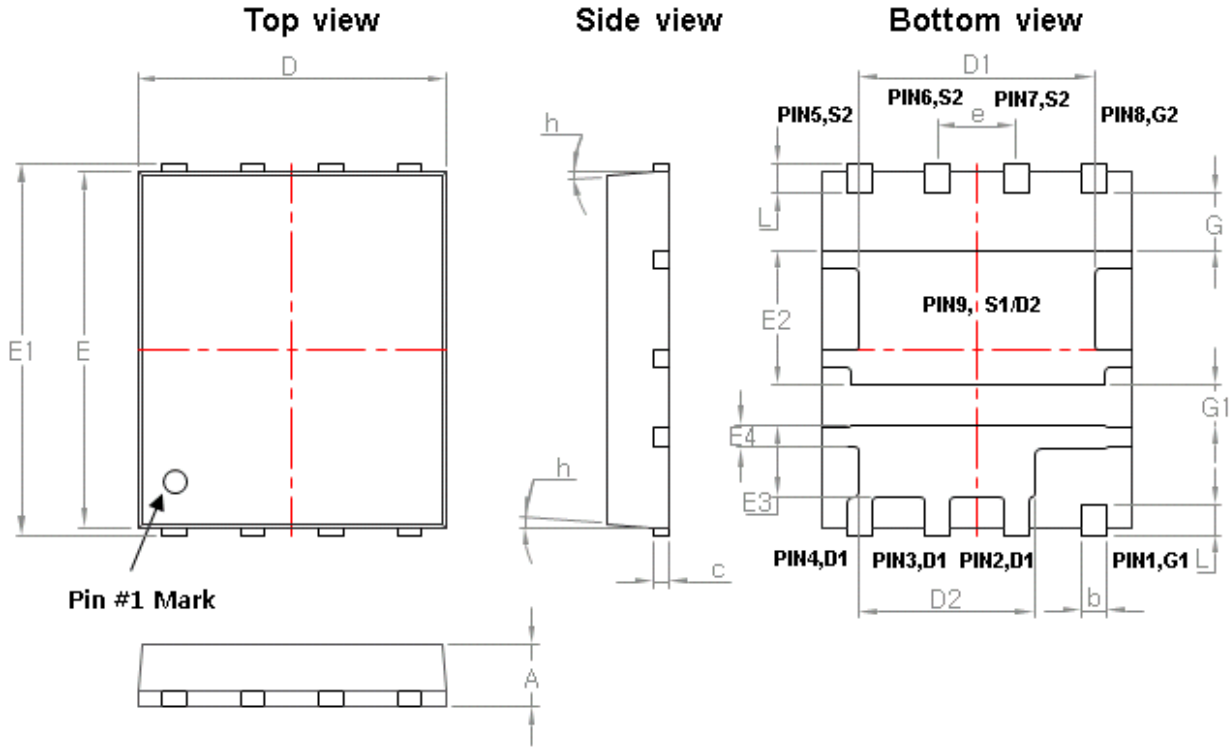


**Fig.11 Transient Thermal Response Curve**

## Package Dimension

### Dual PDFN56 (5x6mm)

Dimensions are in millimeters, unless otherwise specified




Symbol	Dimension [mm]		
	Min	Nom	Max
A	0.90	1.00	1.10
b	0.33	0.41	0.51
c	0.20	0.25	0.30
D	4.80	5.00	5.20
D1	3.60	3.80	4.00
D2	2.64	2.84	3.04
E	5.70	5.75	5.80
E1	5.90	6.00	6.10
E2	2.00	2.25	2.50
E3	1.10	1.20	1.30
E4	0.32	0.42	0.52
e	1.27 BSC		
G	0.50	0.90	1.30
G1	0.40	0.60	0.80
h	0°	-	12°
L	0.38	0.55	0.71



**DISCLAIMER:**

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